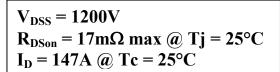
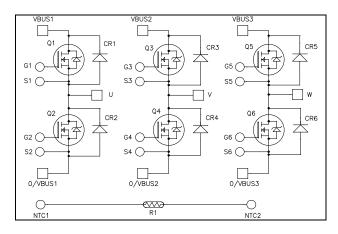
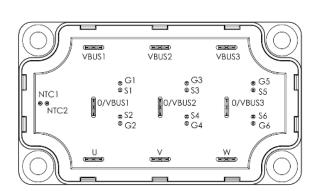


## Triple phase leg SiC MOSFET Power Module







### **Application**

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss

#### SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Very low stray inductance
- Kelvin source for easy drive
- Internal thermistor for temperature monitoring
- High level of integration
- AlN substrate for improved thermal performance

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- **RoHS** Compliant

All ratings @  $T_j = 25$ °C unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



#### **Absolute maximum ratings** (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1200	V
T	L Continuous Lirain Current	$T_c = 25^{\circ}C$	147	
$I_D$		$T_c = 80$ °C	110	Α
$I_{DM}$	Pulsed Drain current		300	
$V_{GS}$	Gate - Source Voltage		-10/25V	V
$R_{DSon}$	Drain - Source ON Resistance		17	mΩ
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	625	W

### **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit	
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 120$			200	μA	
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		12.5	17	
R <sub>DS(on)</sub>		$I_{\rm D} = 100 A$	$T_{j} = 150^{\circ}C$		22	32	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 20 \text{mA}$		2.1	2.4		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.2	μΑ

### **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$			5.6		
$C_{oss}$	Output Capacitance	$V_{\rm DS} = 1000V$			0.44		nF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz			0.03		
$Q_{g}$	Total gate Charge	$V_{GS} = -5/+20V$			322		
$Q_{gs}$	Gate – Source Charge	$V_{\text{Bus}} = 800\text{V}$			92		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 100A$			100		
$T_{d(on)}$	Turn-on Delay Time	$\begin{array}{l} V_{GS} = -5/+20V \\ V_{Bus} = 800V \\ I_D = 100A \ , \ T_J = 150^{\circ}C \\ R_L = 8\Omega \ ; \ R_{Gext} = 10\Omega \end{array}$			35		
$T_{\rm r}$	Rise Time				40		ns
$T_{d(off)}$	Turn-off Delay Time				150		
$T_{\mathrm{f}}$	Fall Time				70		
Eon	Turn on Energy	$V_{GS} = -5/+20V$ $V_{Bus} = 600V$ $I_D = 100A$ $R_{Gext} = 10\Omega$	$T_j = 150^{\circ}C$		2.2		mJ
$E_{\text{off}}$	Turn off Energy		$T_j = 150$ °C		1.2		Ш
$R_{\text{Gint}}$	Internal gate resistance				3		Ω
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	2				0.2	°C/W

# Source - Drain diode ratings and characteristics (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$V_{\mathrm{SD}}$	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 50A$		3.3		V
		$V_{GS} = -2V, I_{SD} = 50A$		3.1		V
$t_{rr}$	Reverse Recovery Time	$I_{SD} = 100A$ ; $V_{GS} = -5V$ $V_{R} = 800V$ ; $di_{F}/dt = 2000A/\mu s$		45		ns
Q <sub>rr</sub>	Reverse Recovery Charge			0.8		μС
$I_{rr}$	Reverse Recovery Current	γκ σουν, αιγαι 2σουν με		26		A



#### SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
$I_{RRM}$	Reverse Leakage Current	rrent $V_R=1200V$	$T_j = 25^{\circ}C$		70	400	μA
1RKM	Reverse Bearage Current		$T_j = 175$ °C		130	800	μΑ
$I_F$	DC Forward Current		Tc = 125°C		40		A
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_r = 40 A$	$T_i = 25^{\circ}C$		1.5	1.8	V
<b>v</b> F			$T_{i} = 175^{\circ}C$		2.2	3	٧
Qc	Total Capacitive Charge	$I_F = 40A, V_R = 1200V$ $di/dt = 1000A/\mu s$			260		nC
C	Total Capacitance	$f = 1MHz, V_R = 400V$			186		pF
		$f = 1MHz, V_R =$	800V		134		pr
$R_{thJC}$	Junction to Case Thermal Resistance					0.55	°C/W

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com).

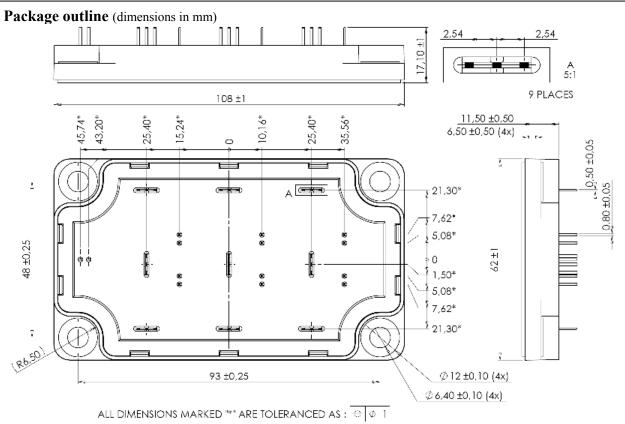
Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
$B_{25/85}$	$T_{25} = 298.15 \text{ K}$			3952		K
$\Delta B/B$		T <sub>C</sub> =100°C		4		%

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]} \quad \begin{array}{l} \text{T: Thermistor temperature} \\ R_T: \text{ Thermistor value at T} \end{array}$$

### Thermal and package characteristics

Symbol	Characteristic			Min	Max	Unit
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t	4000		V		
$T_{J}$	Operating junction temperature range		OSFET	-40	150	
			iode	-40	175	
$T_{JOP}$	Recommended junction temperature under switching conditions				T <sub>J</sub> max -25	°C
$T_{STG}$	Storage Temperature Range				125	
$T_{\rm C}$	Operating Case Temperature	-40	100			
Torque	Mounting torque	To heatsink	M6	3	5	N.m
Wt	Package Weight				250	g

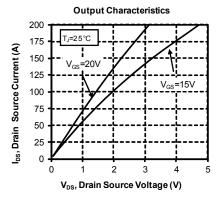


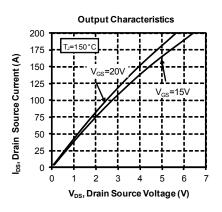


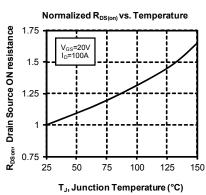
See application note 1902 - Mounting Instructions for SP6-P (12mm) Power Modules on www.microsemi.com

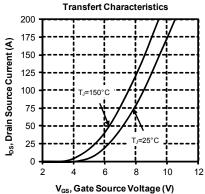


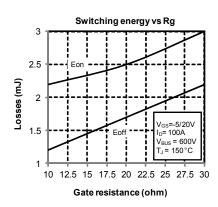
### **Typical SiC MOSFET Performance Curve**

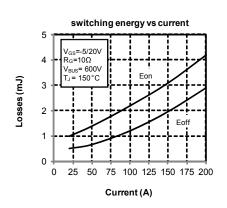




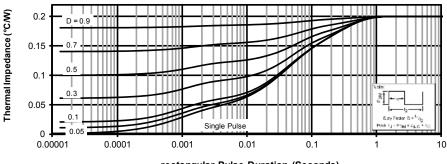






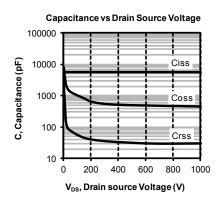


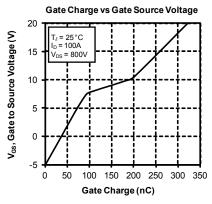


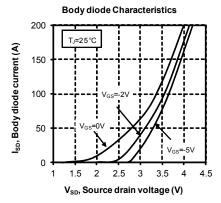


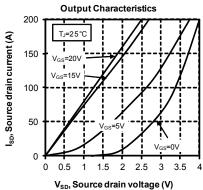
rectangular Pulse Duration (Seconds)

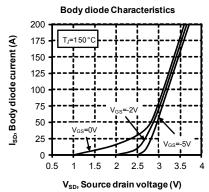


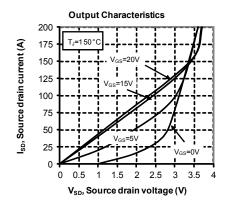


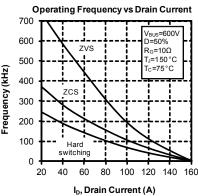














**Typical SiC diode Performance Curve** 

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